

EMC Test Report

Report No.: AGC04094191102EE01

PRODUCT DESIGNATION: Bamboo colour changing 3W

BRAND NAME : N/A

MODEL NAME : P329.34

APPLICANT : Xindao B.V.

DATE OF ISSUE : Dec. 27, 2019

STANDARD(S) : ETSI EN 301489-1 V2.2.3 (2019-11) : D. G. ETGI EN 301 400 47 V2.2.3 (2019-11)

Draft ETSI EN 301 489-17 V3.2.2 (2019-12)

REPORT VERSION : V1.0

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Add: 2/F., Building 2, Sanwei Chaxi Industrial Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China

Tel: +86-755 2523 4088 E-mail: agc@agc-cert.com Service Hotline: 400 089 2118



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Report Revise Record

	Report Version	Revise Time	Issued Date	Valid Version	Notes
9	V1.0	1	Dec. 27, 2019	Valid	Initial release



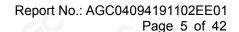
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1. TEST REPORT CERTIFICATION

Applicant	Xindao B.V.
Address	P.O. Box 3082, 2280 GB, Rijswijk, The Netherlands
Manufacturer	Xindao B.V.
Address	P.O. Box 3082, 2280 GB, Rijswijk, The Netherlands
Factory	Xindao B.V.
Address	P.O. Box 3082, 2280 GB, Rijswijk, The Netherlands
Product Designation	Bamboo colour changing 3W
Brand Name	N/A
Test Model	P329.34
Date of test	Nov. 29, 2019~Dec. 27 2019
Deviation	None
Condition of Test Sample	Normal
Test Result	Pass
Report Template	AGCRT-EC-EMC

We, Attestation of Global Compliance (Shenzhen) Co., Ltd., hereby certify that the submitted samples of the above item, as detailed in chapter 2.1 of this report, has been tested in our facility. The test record, data evaluation and test configuration represented herein are true and accurate accounts of measurements of the sample's EMC characteristics under the conditions herein specified.

Prepared By	min Hueng	
	Donjon Huang (Project Engineer)	Dec. 27, 2019
Reviewed By	Max Zhang	
	Max Zhang (Reviewer)	Dec. 27, 2019
Approved By	Forrest les	
. 10	Forrest Lei (Authorized Officer)	Dec. 27, 2019

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2. GENERAL INFORMATION

2.1. DESCRIPTION OF EUT

The EUT is a short range, lower power, Bluetooth device.

It is designed by way of FHSS modulation achieves the system operating.

Details of technical specification refer to the description in follows:

Transmitter/Receiver (TX/RX)

Operating Frequency	2.402 GHz to 2.480GHz
Bluetooth Version	V5.0
Modulation	BR ⊠ GFSK, EDR ⊠ π /4-DQPSK, □ 8DPSK BLE □ GFSK 1Mbps □ GFSK 2Mbps
Hardware Version 1.0	
Software Version	1.0
Antenna Type	PCB Antenna
Number of channels	79 Channels
Antenna Gain -0.58dBi	
Power Supply	DC 3.7V by battery or DC 5V by adapter

Note: The EUT doesn't support BLE.





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2.2. OBJECTIVE

Perform Electro Magnetic Interference (EMI) and Electro Magnetic Susceptibility (EMS) tests for CE Marking.

2.3. TEST STANDARDS AND RESULTS

The EUT has been tested according to ETSI EN 301 489-1 V2.2.3 (2019-11) and Draft ETSI EN 301 489-17 V3.2.2 (2019-12)..

	ElectroMagnetic Compatibility (EMC) standard for radio equipment and services;
ETSI EN 301 489-1	Part 1: Common technical requirements; Harmonised Standard for
	ElectroMagnetic Compatibility.
	ElectroMagnetic Compatibility (EMC) standard for radio equipment and services;
FTCI FN 204 400 47	Part 17: Specific conditions for Broadband Data Transmission Systems;
ETSI EN 301 489-17	Harmonised Standard covering the essential requirements of article 3.1(b) of
	Directive 2014/53/EU

2.4. TEST ITEMS AND THE RESULTS

No.	Basic Standard	Test Type	Result		
EMIS	EMISSION (EN 301 489-1 §7.1)				
1	EN 55032	Radiated emission	PASS		
2	EN 55032	Conducted emission, AC ports	PASS		
3	EN 55032	Conducted emission, Telecom ports	N/A		
4	EN 61000-3-2	Harmonic current emissions	N/A		
5	EN 61000-3-3	Voltage fluctuations & flicker	PASS		
IMM	UNITY (EN 301 489-	1 §7.2)			
6	EN 61000-4-2	Electrostatic discharge immunity	PASS		
7	EN 61000-4-3	Radiated RF electromagnetic field immunity	PASS		
8	EN 61000-4-4	Electrical fast transient/burst immunity	PASS		
9	ISO 7637-1, -2	Transients and surges, DC ports	N/A		
10	EN 61000-4-5	Surge immunity, AC ports, Telecom ports	PASS		
11	EN 61000-4-6	Immunity to conducted disturbances induced by RF fields	PASS		
12	EN 61000-4-11	Voltage dips and short interruptions immunity	PASS		

Note: 1. N/A- Not Applicable.

2. The latest versions of basic standards are applied.

2.5. ENVIRONMENTAL CONDITIONS

During the measurement the environmental conditions were within the listed ranges:

- Temperature: 15-35°C - Humidity: 30-60 %



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- Atmospheric pressure: 86-106 kPa



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3. TEST MODE DESCRIPTION

NO.	EMI TEST MODE DESCRIPTION	WORST
1 0	Standby with charging+Light	V
2	BT Link+charging+Light	
NO.	EMS TEST MODE DESCRIPTION	
1	Standby with charging+Light	V
2	BT Link+charging+Light	

2. All modes have been tested and only the worst mode test data recorded in the test report.

I/O Port Information (☐ Applicable ☐ Not Applicable)

I/O Port of EUT			
I/O Port Type	Number	Cable Description	Tested With
USB Port(for charging)	GO 1	·	1 60

Note: All the above "--" means that EUT has no cable.



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4. MEASUREMENT UNCERTAINTY

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in measurement" (GUM) published by CISPR and ANSI.

- Uncertainty of Radiated Emission, Uc = ±3.2dB
- Uncertainty of Radiated Emission below 1GHz, Uc = ±3.9 dB
- Uncertainty of Radiated Emission above 1GHz, Uc = ±4.8 dB

5. SUPPORT EQUIPMENT

Device Type	Manufacturer	Model Name	Data Cable
Adapter	Zhongli	ZL-PCB0100020502000	+
USB Cable	N/A	N/A	0.6m

Note: 1."-- "means no any support device during testing.

2. All the cables were provided by AGC Lab.





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6. IDENTIFICATION OF THE RESPONSIBLE TESTING LOCATION

Site	Site Attestation of Global Compliance (Shenzhen) Co., Ltd	
Location	1-2/F, Building 19, Junfeng Industrial Park, Chongqing Road, Heping Community,	
Location	Fuhai Street, Bao'an District, Shenzhen, Guangdong, China	

TEST EQUIPMENT OF CONDUCTED EMISSION TEST

Equipment Manufacturer		Model	S/N	Cal. Date	Cal. Due
TEST RECEIVER	TEST RECEIVER R&S		101206	Jun. 12, 2019	Jun. 11, 2020
LISN	LISN R&S		100086	Aug. 26, 2019	Aug. 25, 2020

TEST EQUIPMENT OF RADIATED EMISSION TEST

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Due
Test Receiver	R&S	ESCI	10096	Jun. 12, 2019	Jun. 11, 2020
ANTENNA	SCHWARZBECK	VULB9168	494	Jan. 09, 2019	Jan. 08, 2021
Double-Ridged Waveguide Horn	ETS LINDGREN	3117	00034609	May. 17, 2019	May. 16, 2021
EXA Signal Analyzer	Aglient	N9010A	MY53470504	Dec. 20, 2018	Dec.19, 2019
EXA Signal Analyzer	Aglient	N9010A	MY53470504	Dec.18, 2019	Dec.17, 2020

TEST EQUIPMENT OF POWER HARMONICS / VOLTAGE FLUCTUATION / FLICKER TEST

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Due
Signal Conditioning Unit	Schaffner	CCN1000-1	72431	Aug. 26, 2019	Aug. 25, 2020
AC Source	Schaffner	NSG1007	56825	Aug. 26, 2019	Aug. 25, 2020

TEST EQUIPMENT OF SURGE/EFT/DIPSTEST

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Due
EFT Surge	Schaffner	Modula 6150	34437	Aug. 26, 2019	Aug. 25, 2020
Generator	Schainlei	Modula 6150	34437	Aug. 20, 2019	Aug. 25, 2020

TEST EQUIPMENT OF ESD TEST

Equipment	uipment Manufacturer		S/N	Cal. Date	Cal. Due	
ESD Simulator	Schaffner	NSG 438	782	Oct. 24, 2019	Oct. 23, 2020	



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TEST EQUIPMENT OF RS IMMUNITY TEST

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Due
Signal Generator	R&S	E4421B	MY43351603	Jun. 12, 2019	Jun. 11, 2020
POWER SENSOR	R&S	URV5-Z4	100124	May 17, 2019	May 16, 2020
POWER METER	R&S	NRVD	8323781027	May 17, 2019	May 16, 2020
POWER AMPLIFIER	KALMUS	7100LC	04-02/17-06- 001	Jun. 12, 2019	Jun. 11, 2020
RF AMPLIFIER	Milmega	AS0104-55_55	1004793	Jun. 12, 2019	Jun. 11, 2020
Double-Ridged Waveguide Horn	ETS LINDGREN	3117	00034609	May. 17, 2019	May. 16, 2021
Broadband Preamplifier	ETS LINDGREN	3117PA	00225134	Oct. 15, 2019	Oct. 14, 2020

TEST EQUIPMENT OF CS IMMUNITY TEST

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Due
Power Amplifier	AR	75A250	18464	Jun. 12, 2019	Jun. 11, 2020
CDN	ZHINAN	ZN3751	15004	Sep. 09, 2019	Sep. 08, 2020
6dB attenuator	ZHINAN	E-002	N/A	Sep. 09, 2019	Sep. 08, 2020
Electromagnetic Injection Clamp	Luthi	EM101	35773	Sep. 27, 2019	Sep. 26, 2020
Power Sensor	R&S	URV5-Z4	100124	May 17, 2019	May 16, 2020
Power Meter	R&S	NRVD	8323781027	May 17, 2019	May 16, 2020
SIGNAL GENERATOR	R&S	E4421B	MY43351603	Jun. 12, 2019	Jun. 11, 2020



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7. RADIATED DISTURBANCE MEASUREMENT

7.1. LIMITS OF RADIATED DISTURBANCES

Limits for radiated disturbance 30M to1 GHz at a measurement distance of 3 m

Frequency range (MHz)	Quasi peak limits(dBuV/m), for Class B ITE, at 3m measurement distance
30 - 230	40
230 - 1000	47

Limits for radiated disturbance above 1 GHz at a measurement distance of 3 m

Eraguanay ranga (MHz)	Limits (dB	uV/m), Class B ITE
Frequency range (MHz)	Peak	Average
1000-3000MHz	70	50
3000-6000MHz	74	54

Note: 1. The lower limit shall apply at the transition frequency.

2. Additional provisions may be required for cases where interference occurs.

7.2. TEST PROCEDURE

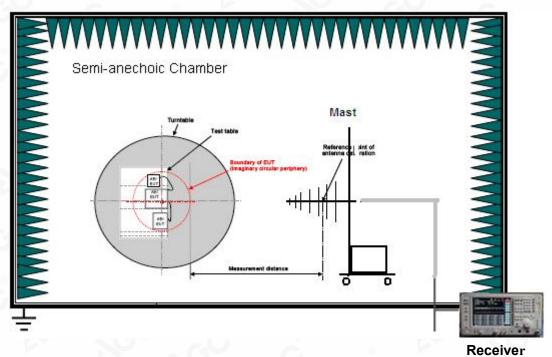
- (1). The EUT was placed on the top of an insulating table 0.8 meters above the ground at a semi-anechoic chamber. The table was rotated 360 degrees to determine the position of the highest radiation.
- (2). The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- (3). The antenna is a broadband antenna, and its height is varied from 1 to 4 meter above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- (4). For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to the heights from 1 to 4 meters and the ratable table was turned from 0 degrees to 360 degrees to find the maximum reading.



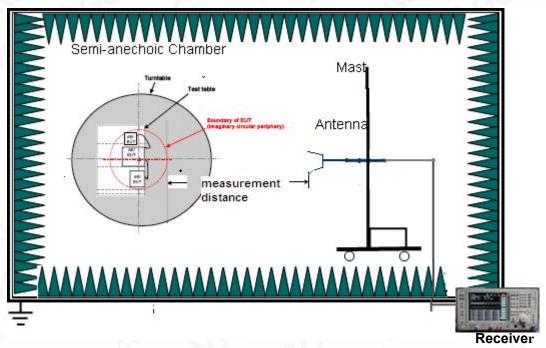


7.3. BLOCK DIAGRAM OF TEST SETUP

Radiated Disturbance below 1 GHz



Radiated Disturbance above 1 GHz

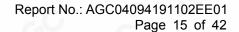


For the actual test configuration, please refer to the related item-Photographs of the Test Configuration.



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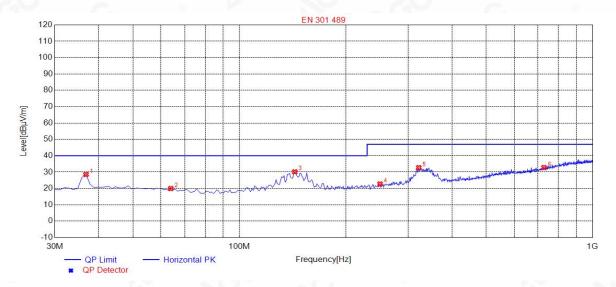


7.4. TEST RESULT

The test modes were carried out for all modes.

The worst test mode of the EUT was Mode 1, and its test data was showed as the follow:

RADIATED EMISSION BELOW 1GHz-HORIZONTAL



NO	Freq.	Level	Factor	Limit	Margin	Height	Angle	Dolority	
NO.	[MHz]	[dBµV/m]	[dB]	[dBµV/m]	[dB]	[cm]	[°]	Polarity	
1	36.7900	28.56	14.16	40.00	11.44	100	174	Horizontal	
2	63.9500	19.95	13.25	40.00	20.05	200	124	Horizontal	
3	143.4900	30.15	14.88	40.00	9.85	200	323	Horizontal	
4	250.1900	22.72	14.69	47.00	24.28	100	140	Horizontal	
5	321.9700	32.71	16.77	47.00	14.29	100	99	Horizontal	
6	728.4000	32.80	26.67	47.00	14.20	200	359	Horizontal	

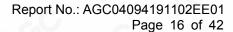
RESULT: PASS



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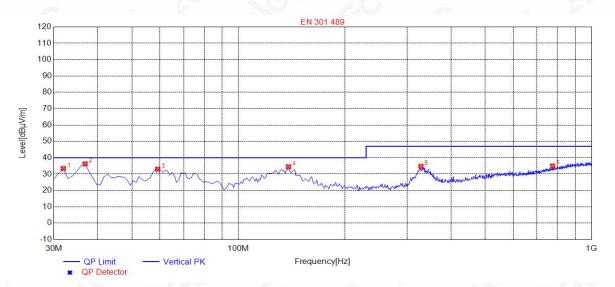
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RADIATED EMISSION BELOW 1GHz- VERTICAL



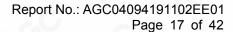
NO.	Freq.	Level	Factor	Limit	Margin	Height	Angle	Dolority	
NO.	[MHz]	[dBµV/m]	[dB]	[dBµV/m]	[dB]	[cm]	[°]	Polarity	
1	31.9400	33.40	13.19	40.00	6.60	100	113	Vertical	
2	36.7900	36.23	14.16	40.00	3.77	100	357	Vertical	
3	59.1000	33.00	13.98	40.00	7.00	100	118	Vertical	
4	138.6400	34.47	14.78	40.00	5.53	100	186	Vertical	
5	328.7600	34.69	17.02	47.00	12.31	100	152	Vertical	
6	775.9300	34.97	27.83	47.00	12.03	100	210	Vertical	

RESULT: PASS



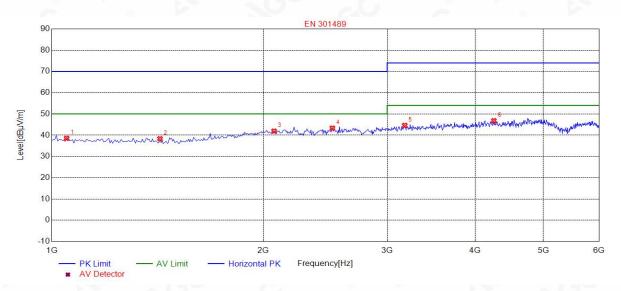
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RADIATED EMISSION ABOVE 1GHz - HORIZONTAL



NO	Freq.	Level	Factor	Limit	Margin	Height	Angle	Dalasita
NO.	[MHz]	[dBµV/m]	[dB]	[dBµV/m]	[dB]	[cm]	[°]	Polarity
1	1050.0501	38.56	-16.69	70.00	31.44	100	168	Horizontal
2	1425.4254	38.34	-17.06	70.00	31.66	100	36	Horizontal
3	2071.0711	41.93	-11.52	70.00	28.07	100	297	Horizontal
4	2506.5065	43.34	-9.71	70.00	26.66	100	351	Horizontal
5	3177.1772	44.60	-8.72	74.00	29.40	100	216	Horizontal
6	4253.2533	46.82	-5.84	74.00	27.18	100	265	Horizontal

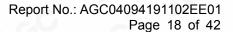
RESULT: PASS



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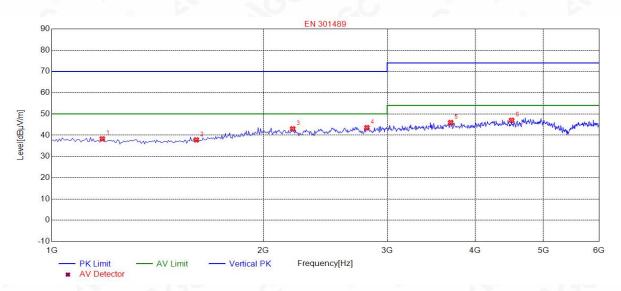
Add: 2/F., Building 2, Sanwei Chaxi Industrial Park, Sanwei Community,

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RADIATED EMISSION ABOVE 1GHz - VERTICAL



NO	Freq.	Level	Factor	Limit	Margin	Height	Angle	Dalasita.
NO.	[MHz]	[dBµV/m]	[dB]	[dBµV/m]	[dB]	[cm]	[°]	Polarity
1	1180.1802	38.28	-16.82	70.00	31.72	100	147	Vertical
2	1605.6056	37.78	-16.01	70.00	32.22	100	144	Vertical
3	2201.2012	42.99	-10.97	70.00	27.01	100	58	Vertical
4	2806.8068	43.56	-9.48	70.00	26.44	100	224	Vertical
5	3692.6927	45.95	-7.18	74.00	28.05	100	32	Vertical
6	4508.5085	46.99	-5.19	74.00	27.01	100	304	Vertical

RESULT: PASS



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8. MAINS TERMINAL DISTURBANCE VOLTAGE MEASUREMENT

8.1. LIMITS OF MAINS TERMINAL DISTURBANCE VOLTAGE

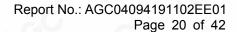
Francisco de von de (MIII-)	Limits (dBuV) Class B ITE				
Frequency range (MHz)	Quasi-peak	Average			
0.15 - 0.50	66 to 56	56 to 46			
0.50 - 5	56	46			
5 - 30	60	50			

Note: 1. The lower limit shall apply at the transition frequencies.

2. The limit decreases linearly with the logarithm of the frequency in the range 0.15MHz to 0.50MHz.

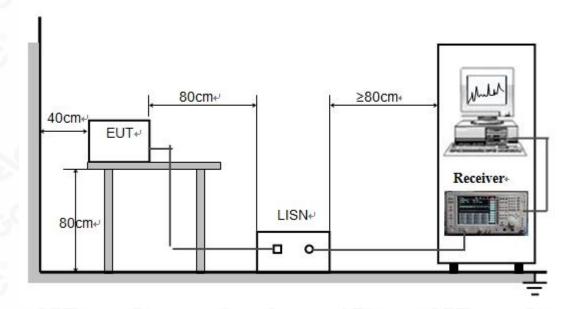
8.2. TEST PROCEDURE

- (1) The EUT was placed 0.4 meters from the conducting wall of shielded room with EUT being connected to the power mains through a line impedance stabilization network (LISN). The LISN provide $50\Omega/50\mu H$ of coupling impedance for the measuring instrument.
- (2) Both lines of the power mains connected to the EUT were checked for maximum conducted interference.
- (3)The frequency range from 150 kHz to 30 MHz was searched. Emission levels over 20dB under the prescribed limits are not reported.





8.3. TEST SETUP



For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.

8.4. TEST RESULT

The test modes were carried out for all modes.

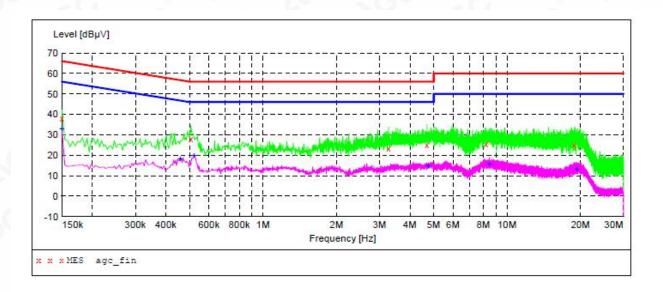
The worst test mode of the EUT was Mode 1, and its test data was showed as the follow:







LINE CONCUTED EMISSION TEST-L



MEASUREMENT RESULT: "agc fin"

2019/1	2/4 19:	11						
	quency MHz		Transd dB	Limit dBµV	Margin dB	Detector	Line	PE
0.	150000	37.90	10.7	66	28.1	QP	L1	FLO
0.	506000	28.00	11.0	56	28.0	QP	L1	FLO
3.	270000	23.30	11.3	56	32.7	QP	L1	FLO
4.	698000	25.20	11.3	56	30.8	QP	L1	FLO
8.	210000	25.70	11.4	60	34.3	QP	L1	FLO
18.	870000	24.90	12.2	60	35.1	OP	L1	FLO

MEASUREMENT RESULT: "agc_fin2"

2	019/12/4 19:	11						
	Frequency MHz	Level dBµV	Transd dB	Limit dBµV	Margin dB	Detector	Line	PE
	0.150000	32.90	10.7	5.6	23.1	AV	L1	FLO
	0.458000	18.30	11.0	47	28.4	AV	L1	FLO
	0.522000	19.90	11.0	46	26.1	AV	L1	FLO
	4.754000	15.20	11.3	46	30.8	AV	L1	FLO
	8.466000	16.00	11.4	50	34.0	AV	L1	FLO
	19.326000	13.40	12.3	50	36.6	AV	L1	FLO



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LINE CONCUTED EMISSION TEST-N

Level [dBµV] 50 30 -10 150k Frequency [Hz] ии и MES agc_fin

MEASUREMENT RESULT: "agc_fin"

2	019/12/4 19:	15						
	Frequency MHz	Level dBµV	Transd dB	Limit dBµV	Margin dB	Detector	Line	PE
	0.150000	37.60	10.7	66	28.4	QP	N	FLO
	0.526000	25.40	11.0	56	30.6	QP	N	FLO
	4.014000	22.80	11.3	56	33.2	QP	N	FLO
	4.934000	24.80	11.3	56	31.2	QP	N	FLO
	8.874000	21.40	11.5	60	38.6	QP	N	FLO
	19.870000	25.40	12.3	60	34.6	QP	N	FLO

MEASUREMENT RESULT: "agc_fin2"

2019/12/4 19	:15						
Frequency MHz	Level dBµV	Transd dB	Limit dBµV	Margin dB	Detector	Line	PE
0.150000	32.90	10.7	56	23.1	AV	N	FLO
0.526000	17.10	11.0	46	28.9	AV	N	FLO
4.010000	11.30	11.3	46	34.7	AV	N	FLO
4.934000	12.30	11.3	46	33.7	AV	N	FLO
8.842000	11.80	11.5	50	38.2	AV	N	FLO
19.870000	13.00	12.3	50	37.0	AV	N	FLO



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9. HARMONIC CURRENT MEASUREMENT

9.1. LIMITS OF HARMONIC CURRENT

Limits fo	or Class A Equipment					
Harmonics Order n	Max. permissible harmonic current (A)					
Odd harmonics						
3	2.30					
5	1.14					
7	0.77					
9	0.40					
911	0.33					
13	0.21					
15≤n≤39	0.15×15/n					
E	ven harmonics					
2	1.08					
4	0.43					
6	0.30					
8≤n≤40	0.23×8/n					

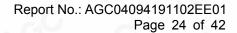
Note: 1. According to section 5 of EN61000-3-2: 2014, the EUT is Class C equipment.

2. The above limits are for all applications having an active input power>75W. No limits apply for equipment with an active input power up to and including 75W.

9.2. TEST PROCEDURE

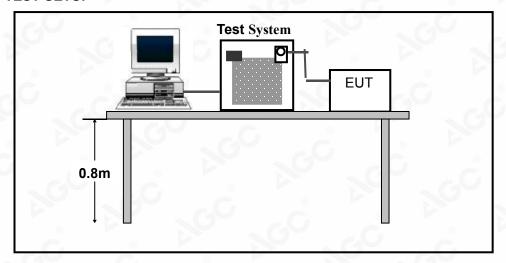
- 1. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.
- 2. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the necessary for the EUT to be exercised.







9.3. TEST SETUP



For the actual test configuration, please refer to Appendix I: Photographs of the Test Configuration.

9.4. TEST RESULT

No applicable for equipment with an active input power up to and including 75W.





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10. VOLTAGE FLUCTUATIONS AND FLICK MEASUREMENT

10.1. LIMITS OF VOLTAGE FLUCTUATIONS AND FLICK

Test Item	Limit	Note
P _{st}	1.0	P _{st} means Short-term flicker indicator
P _{lt}	0.65	P _{lt} means long-term flicker indicator
T _{dt}	0.2	T _{dt} means maximum time that d _t exceeds 3%
d _{max} (%)	4%	d _{max} means maximum relative voltage change.
d _c (%)	3%	d _c means relative steady-state voltage change

10.2. TEST PROCEDURE

- 1. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal conditions
- 2. During the flick measurement, the measure time shall include that part of whole operation changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

10.3. TEST SETUP

Same as 9.3

10.4. TEST RESULT

Test Specification

Test Frequency	50Hz	Test Voltage	230V AC
Waveform	Sine	Test Time	10 minutes(P _{st}); 2 hours (P _{lt})

Test Result

Test Parameter	Measurement Value	Limit	Remarks
P _{st}	0.160	1.0	Pass
P _{lt}	0.070	0.65	Pass
$T_{dt(s)}$	0.00	0.2	Pass
d _{max} (%)	0.11%	4%	Pass
d _c (%)	0.23%	3%	Pass



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11. IMMUNITY TEST

11.1. EUT SETUP AND OPERATING CONDITIONS

Each immunity test was performed according to the requirements of the standard.

11.2. GENERAL PERFORMANCE CRITERIA

1. Performance criteria for Continuous phenomena applied to Transmitter (CT)

The performance criteria A shall apply.

Tests shall be repeated with the EUT in standby mode (if applicable) to ensure that unintentional transmission does not occur. In systems using acknowledgement signals, it is recognized that an ACKnowledgement (ACK) or Not ACKnowledgement (NACK) transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

2. Performance criteria for Transient phenomena applied to Transmitter (TT)

The performance criteria B shall apply, except for voltage dips of 100 ms and voltage interruptions of 5 000 ms

duration, for which performance criteria C shall apply.

Tests shall be repeated with the EUT in standby mode (if applicable) to ensure that unintentional transmission does not occur. In systems using acknowledgement signals, it is recognized that an acknowledgement (ACK) or not-acknowledgement (NACK) transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

3. Performance criteria for Continuous phenomena applied to Receiver (CR)

The performance criteria A shall apply.

Where the EUT is a transceiver, under no circumstances, shall the transmitter operate unintentionally during the test. In systems using acknowledgement signals, it is recognized that an ACK or NACK transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

4. Performance criteria for Transient phenomena applied to Receiver (TR)

The performance criteria B shall apply, except for voltage dips of 100 ms and voltage interruptions of 5 000 ms duration for which performance criteria C shall apply.

Where the EUT is a transceiver, under no circumstances, shall the transmitter operate unintentionally during the test. In systems using acknowledgement signals, it is recognized that an ACK or NACK transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.





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12. ELECTROSTATIC DISCHARGE IMMUNITY TEST

12.1. TEST SPECIFICATION

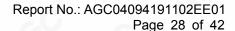
Basic Standard EN 61000-4-2			
Discharge Impedance	330Ω / 150 pF		
Discharge Voltage Air Discharge –8 kV, Contact Discharge – 4 kV			
Polarity Positive / Negative			
Number of Discharge	Minimum 20 times at each test point		
Discharge Mode	Single discharge		
Discharge Period	1-second minimum		

12.2. TEST PROCEDURE

The test procedure was in accordance with EN 61000-4-2:

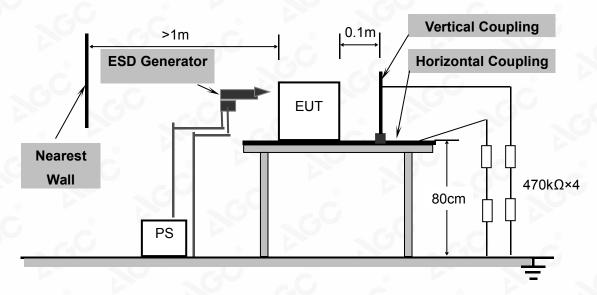
- a. Electrostatic discharges were applied only to those points and surfaces of the EUT that are accessible to users during normal operation.
- b. The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.
- c. The time interval between two successive single discharges was at least 1 second.
- d. The ESD generator was held perpendicularly to the surface to which the discharge was applied and the return cable was at least 0.2 meters from the EUT.
- e. Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- f. Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were completed.
- g. At least ten single discharges (in the most sensitive polarity) were applied to the Horizontal Coupling Plane at points on each side of the EUT. The ESD generator was positioned vertically at a distance of 0.1 meters from the EUT with the discharge electrode touching the HCP.
- h. At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the Vertical Coupling Plane in sufficiently different positions that the four faces of the EUT were completely illuminated. The VCP (dimensions 0.5m×0.5m) was placed vertically to and 0.1 meters from the EUT.







12.3. TEST SETUP



For the actual test configuration, please refer to Appendix I: Photographs of the Test Configuration.

12.4. TEST RESULT

Criteria	During Test	After Test	
G	Shall operate as intended.	Shall operate as intended.	
^	May show degradation of performance(see note 1).	Shall be no degradation of performance (see note 2).	
A	Shall be no loss of function.	Shall be no loss of function.	
	Shall be no unintentional transmissions.	Shall be no loss of stored data or user programmable functions.	
В	May show loss of function (one or more). May show degradation of performance (see note 1). No unintentional transmissions.	Functions shall be self-recoverable. Shall operate as intended after recovering. Shall be no degradation of performance (see note 2). Shall be no loss of stored data or user programmable functions.	

NOTE 1: Degradation of performance during the test is understood as a degradation to a level not below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some cases the specified minimum performance level may be replaced by a permissible degradation of performance.

If the minimum performance level or the permissible performance degradation is not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect from the apparatus if used as intended.

NOTE 2: No degradation of performance after the test is understood as no degradation below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some cases the specified minimum performance level may be replaced by a permissible degradation of performance. After the test no change of actual operating data or user retrievable data is allowed. If the minimum performance level or the permissible performance degradation is not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect from the apparatus if used as intended.



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DESCRIPTION OF THE ELECTROSTATIC DISCHARGES (ESD)

Amount of Discharges	Voltage	Coupling	Observation	Performance	Result (Pass/Fail)
Mini 20 / Point	±2KV, ±4kV	Contact Discharge	No Function Loss	Α	Pass
Mini 20 / Point	±2KV, ±4kV, ±8kV	Air Discharge	No Air Discharge	N/A	N/A
Mini 20 / Point	±2KV, ±4kV	Indirect Discharge HCP	No Function Loss	Α	Pass
Mini 20 / Point	±2KV, ±4kV	Indirect Discharge VCP	No Function Loss	Α	Pass

Note: operating mode include all modes of EMS in page 8.





Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China
Tel: +86-755 2523 4088 E-mail:agc@agc-cert.com Service Hotline:400 089 2118



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12.5. PERFORMANCE

⊠ Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
☐ Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
☐ Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

DACC	TAU	
⊠ PASS		
_	_	



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13. RADIATED, RADIO FREQUENCY ELECTROMAGNETIC FIELD IMMUNITY TEST 13.1. TEST SPECIFICATION

10.11. I EOT OF EOTI TOAT	1011
Basic Standard	EN 61000-4-3
Frequency Range	80 MHz – 6000MHzMHz
Field Strength	3V/m
Modulation	1 kHz sine wave, 80%, AM modulation
Frequency Step	1% of fundamental
Polarity of Antenna	Horizontal and Vertical
Test Distance	3m
Antenna Height	1.5m
Dwell Time	3 seconds

13.2. TEST PROCEDURE

The test procedure was in accordance with EN 61000-4-3.

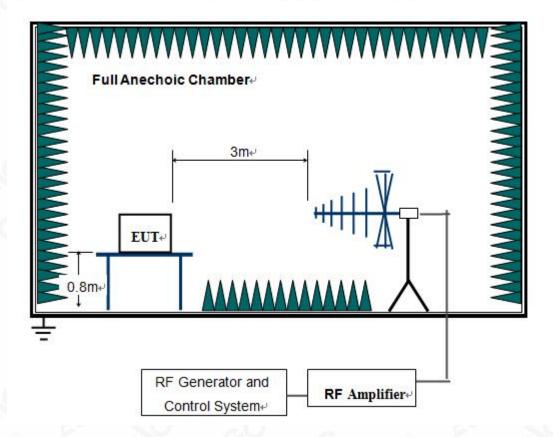
- a. The testing was performed in a fully anechoic chamber. The transmit antenna was located at a distance of 3 meters from the EUT.
- b. The test signal was 80% amplitude modulated with a 1 kHz sine wave.
- c. The frequency range was swept from 80 MHz to 6000MHz with the exception of the exclusion band for transmitters, receivers and duplex transceivers. The rate of sweep did not exceed 1.5×10⁻³ decade/s. Where the frequency range is swept incrementally, the step size was 1% of fundamental.
- d. The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.
- e. The field strength level was 3V/m.
- f. The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.







13.3. TEST SETUP



For the actual test configuration, please refer to Appendix A: Photographs of the Test Configuration.



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13.4. TEST RESULT

Criteria	During Test	After Test		
A	Shall operate as intended. May show degradation of performance (see note 1). Shall be no loss of function. Shall be no unintentional transmissions.	Shall operate as intended. Shall be no degradation of performance (see note 2). Shall be no loss of function. Shall be no loss of stored data or user programmable functions.		

NOTE 1: Degradation of performance during the test is understood as a degradation to a level not below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some cases the specified minimum performance level may be replaced by a permissible degradation of performance.

If the minimum performance level or the permissible performance degradation is not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect from the apparatus if used as intended.

NOTE 2: No degradation of performance after the test is understood as no degradation below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some cases the specified minimum performance level may be replaced by a permissible degradation of performance. After the test no change of actual operating data or user retrievable data is allowed. If the minimum performance level or the permissible performance degradation is not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect from the apparatus if used as intended.

Freq. Range (MHz)	Field	Modulation	Polarity	Position	Observation	performance	Result (Pass/Fail)
80-6000	3V/m	Yes	H/V	Front	No Function Loss	A	PASS
80-6000	3V/m	Yes	H/V	Back	No Function Loss	A	PASS
80-6000	3V/m	Yes	H/V	Left	No Function Loss	А	PASS
80-6000	3V/m	Yes	H/V	Right	No Function Loss	Α	PASS
80-6000	3V/m	Yes	H/V	Тор	No Function Loss	Α	PASS
80-6000	3V/m	Yes	H/V	Bottom	No Function Loss	Α	PASS

Note: operating mode include all modes of EMS in page 8.



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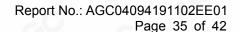


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13.5. PERFORMANCE

⊠ Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
☐ Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
☐ Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

		(0.)		
	₩ DACC	•		
	⊠ PASS	•		





14. ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST

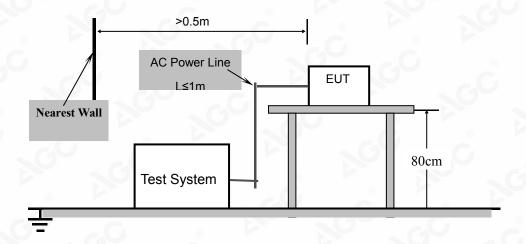
14.1. TEST SPECIFICATION

Basic Standard	IEC 61000-4-4
Test Voltage	a.c. power port – 1 kV
Polarity	Positive/Negative
Impulse Frequency	5kHz
Impulse wave shape	5/50ns
Burst Duration	15ms
Burst Period	300ms
Test Duration	Not less than 1 min.

14.2. TEST PROCEDURE

- 1. The EUT was tested with 1000 volt discharges to the AC power input leads.
- 2. Both positive and negative polarity discharges were applied.
- 3. The length of the "hot wire" from the coaxial output of the EFT generator to the terminals on the EUT should not exceed 1 meter.
- 4. The duration time of each test sequential was 1 minute.
- 5. The transient/burst waveform was in accordance with IEC 61000-4-4, 5/50ns.

14.3. TEST SETUP



For the actual test configuration, please refer to Appendix I: Photographs of the Test Configuration.



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14.4. TEST RESULT

Test Point	Polarity	Test Level (kV)	Observation	performance	Conclusion
a.c. port, L	+/-	1,0	No function loss	Α	Pass
a.c. port, N	+/-	1	No function loss	Α	Pass
a.c. port, L-N	+/-	1	No function loss	Α	Pass

Note: operating mode include all modes of EMS in page 8.

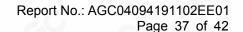
14.5. PERFORMANCE

⊠ Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
☐ Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
☐ Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

⊠ PASS ☐ FAIL	



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15. SURGE IMMUNITY TEST

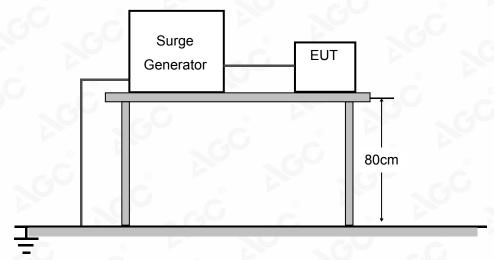
15.1.TEST SPECIFICATION

Basic Standard	EN 61000-4-5
Waveform	Voltage 1.2/50 μs; Current 8/20 μs
Test Voltage	a.c. power port, line to line 1.0 kV
Polarity	Positive/Negative
Phase Angle	0°, 90°, 180°, 270°
Repetition Rate	60sec
Times	5 time/each condition.

15.2. TEST PROCEDURE

- a. The EUT and the auxiliary equipment were placed on a table of 0.8m heights above a metal ground reference plane. The size of ground plane is greater than 1m×1m and project beyond the EUT by at least 0.1m on all sides. The ground plane is connected to the protective earth. The length of power cord between the coupling device and the EUT was less than 2 meters (provided by the manufacturer).
- b. The EUT was connected to the power mains through a coupling device that directly couples the surge interference signal. The surge noise was applied synchronized to the voltage phase at the zero crossing and the peak value of the AC voltage wave (positive and negative).
- c. The surges were applied line to line and line(s) to earth. All lower levels including the selected test level were tested. The polarity of each surge level included positive and negative test pulses.

15.3. TEST SETUP



For the actual test configuration, please refer to Appendix I: Photographs of the Test Configuration.



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15.4. TEST RESULT

Coupling Line	Polarity	Voltage (kV)	Observation	performance	Conclusion	
a.c. power, L-N	+/-	1.0	No function loss	Α	Pass	

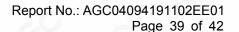
Note: operating mode include all modes of EMS in page 8.

15.5. PERFORMANCE

⊠ Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
☐ Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
☐ Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

oxtimes PASS $oxtimes$ FAIL			⊠ PASS	☐ FAIL		
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16. IMMUNITY TO CONDUCTED DISTURBANCES INDUCED BY RF FIELDS

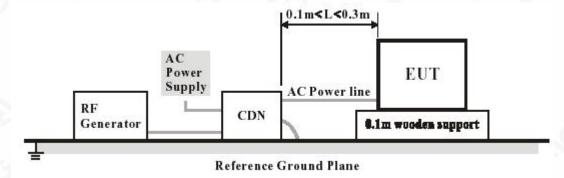
16.1. TEST SPECIFICATION

Basic Standard	EN 61000-4-6
Frequency Range	0.15 MHz – 80 MHz
Field Strength	3Vrms
Modulation	1 kHz Sine Wave, 80% AM
Frequency Step	1% of fundamental
Coupled Cable	a.c. power line
Coupling Device	CDN-M2

16.2. TEST PROCEDURE

- 1. The EUT shall be tested within its intended operating and climatic conditions.
- 2. The test shall be performed with the test generator connected to each of the coupling and decoupling devices in turn, while the other non-excited RF input ports of the coupling devices are terminated by a 50-ohm load resistor.
- 3. The test signal was 80% amplitude modulated with a 1 kHz sine wave
- 4. The frequency range is swept from 150 kHz to 80 MHz, using the signal level established during the setting process and with a disturbance signal of 80% amplitude. The sweep rate shall not exceed 1.5×10-3 decades/s. The step size shall not exceed 1% of the start and thereafter 1% of the preceding frequency value where the frequency is swept incrementally.
- 5. The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised, and able to respond. Sensitive frequencies such as clock frequencies and harmonics or frequencies of dominant interest, shall be analyzed separately.
- Attempts should be made to fully exercise the EUT during test, and to fully interrogate all exercise modes selected for susceptibility.

16.3. TEST SETUP



For the actual test configuration, please refer to Appendix I: Photographs of the Test Configuration.



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16.4. TEST RESULT

EUT Working Mode	e Test Point Frequence (MHz)		Field Strength (Vrms)	Observation	performance	Conclusion	
Normal	Normal a.c. port		3	No function loss	A	Pass	

Note: operating mode include all modes of EMS in page 8.

16.5. PERFORMANCE

⊠ Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
☐ Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
☐ Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

	(36)			
	⊠ PΔS	, C	ΠEΛΙΙ	
	PAS	.o	<i>FAIL</i>	
		\sim		



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17. VOLTAGE DIPS AND SHORT INTERRUPTIONS IMMUNITY TEST

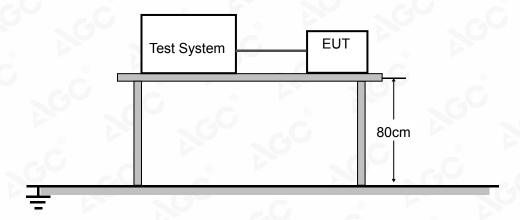
17.1. TEST SPECIFICATION

Basic Standard	EN 61000-4-11
	100% reduction, 0.5 Cycle
Voltage Dips	100% reduction, 1.0 Cycle
	30% reduction, 25 Cycles
Voltage Interruptions	100% reduction, 250 Cycles
Voltage Phase Angle	0°, 45°, 90°, 135°, 180°, 225°, 270°, 315°

17.2. TEST PROCEDURE

- a). The power cord was used as supplied by the manufacturer. The EUT was connected to the line output of the Voltage Dips and Interruption Generator.
- b). The EUT was tested for (1) 100% voltage dip of supplied voltage with duration of 0.5 cycles, (2)100% voltage dip of supplied voltage and duration 1.0 cycle. (3) 30% voltage dip of supplied voltage and duration 25 cycles. (4) 100% voltage interruption of supplied voltage with duration of 250 Cycles was followed.
- c). Voltage reductions occur at 0 degree crossover point of the voltage waveform. The performance of the EUT was checked after the voltage dip or interruption.

17.3. TEST SETUP



For the actual test configuration, please refer to Appendix I: Photographs of the Test Configuration.





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17.4. TEST RESULT

Test Mode	Voltage Reducti on	Duration (cycle)	Times	Interval (ms)	Observation	performance	Conclusion
r.C	100%	0.5	3	10	No function loss	В	Pass
Voltage dips	100%	1	3	20	No function loss	С	Pass
8	30%	25	3	500	No function loss	С	Pass
Voltage interruptions	100%	250	3	5000	No function loss	С	Pass

Note: operating mode include all modes of EMS in page 8.

17.5. PERFORMANCE

☐ Criteria A:	The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
⊠ Criteria B:	The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
⊠ Criteria C:	Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

		⊠ PASS	□ FAIL		
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APPENDIX A: PHOTOGRAPHS OF TEST SETUP

Refer to Attached file (Appendix I).

APPENDIX B: PHOTOGRAPHS OF EUT

Refer to Attached file (Appendix I).

----END OF REPORT----

